

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/714,654	TAKEKOSHI ET AL.
	<b>Examiner</b> Randolph Chu	<b>Art Unit</b> 2624

**SEARCHED**

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	6/6/2007	RIC
Inventor Name Search	6/6/2007	RIC
Consult with Wenpeng Chen	6/6/2007	ric

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner